

Notice of References Cited

Application/Control No.

10/650,191

Applicant(s)/Patent Under
Reexamination
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Examiner

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Art Unit

2193

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U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-			
	B	US-			
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FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	M. Christodorescu et al., "Static Analysis of Executables to Detect Malicious Patterns", 18 February 2003.
	V	M. Christodorescu et al., "Static Analysis of Binaries for Malicious Code Detection", 7 August 2003.
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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